



Life testing of segmented high efficiency thermoelectric couples

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California Institute of Technology**

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Outline

- **Introduction**
 - Evolution of RTG
 - High efficiency thermoelectric couple
 - Evaluating life time performance of thermoelectric couples
- **Component life test**
 - Sublimation life test
 - Thermoelectric properties life test
 - Contact resistance life test
 - Status of TE materials for high efficiency couples
- **Couple life test**
- **Summary**

The evolution of RTGs

MHW-RTG

TRL 9-10



158 We
4.2W/kg

6. 6% Efficiency

> 30 Year life demonstrated
- *LES 8/9, Voyager 1 & 2*

SNAP-19

TRL 9-10

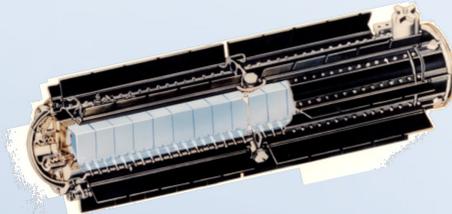
40 We
3 W/kg

6. 2% Efficiency

>14 Year life
> *Pioneer 10&11, Viking 1 & 2*

GPHS-RTG

TRL 9-10



283We
5.1 W/kg

6. 8% Efficiency

> 18 Year life demonstrated

- *Ulysses, Galileo, Cassini, New Horizons*

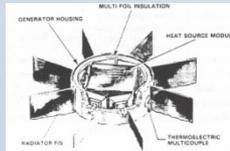
MOD-RTG

TRL 3-6

330 We
7.7 W/kg

6. 8% Efficiency (Si-Ge)

> 14 Year life

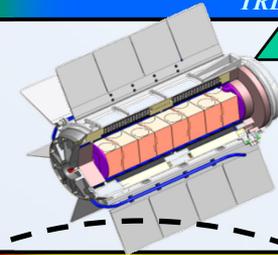


Projected Performance

MMRTG

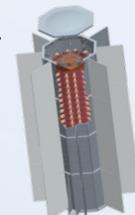
125 We
2.8 W/kg

6.3% Efficiency
- *MSL*

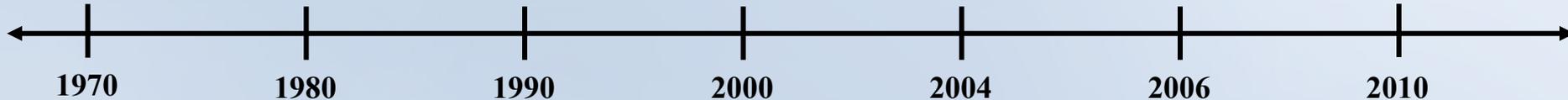


ARTG

6-8 W/kg
> 10% efficiency

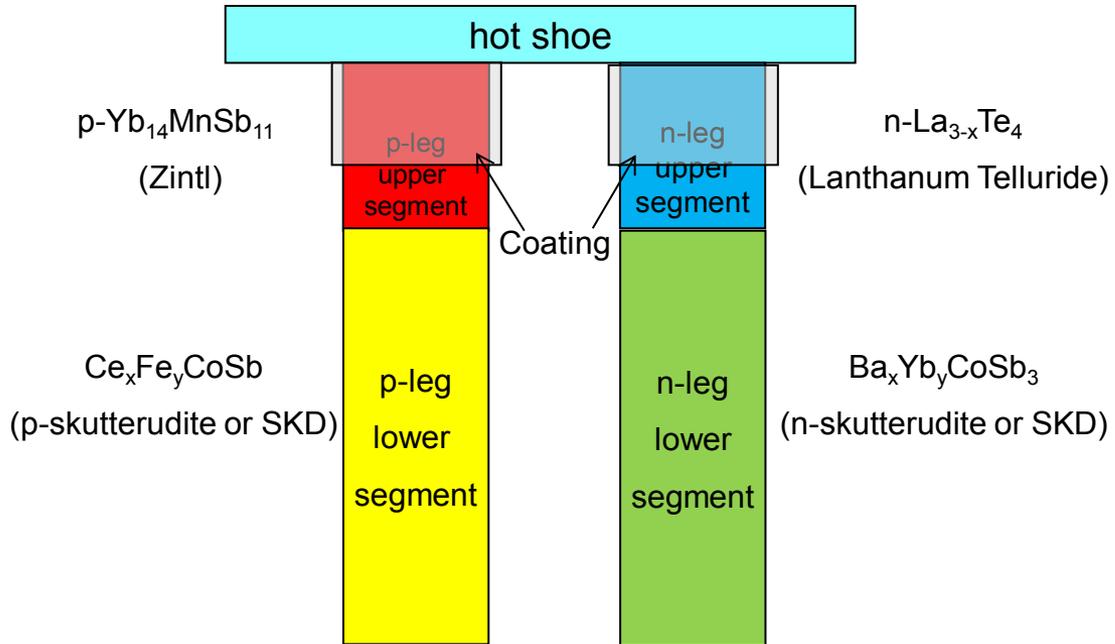


Requires > 12% efficient couple technology

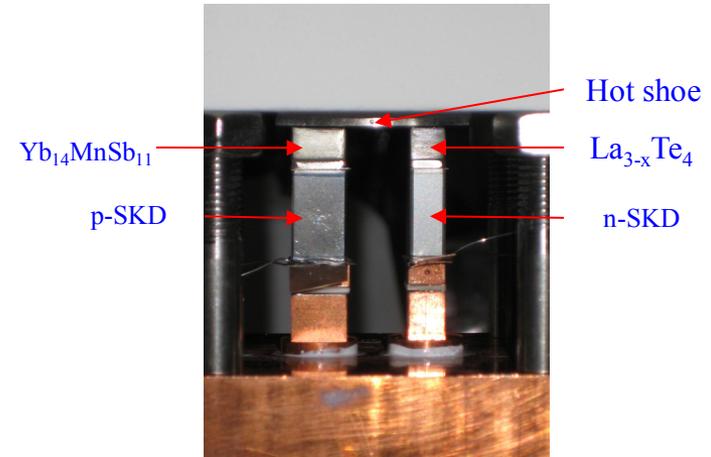




High efficiency thermoelectric couple



Simplified scheme of a segmented couple



**Segmented high efficiency thermoelectric couple
(up to 15% efficiency, up to 1273 K hot side operation)**



What controls RTGs Lifetime Performance?

Degradation mechanisms



1. Fuel decay (Reduced heat from GPHS)

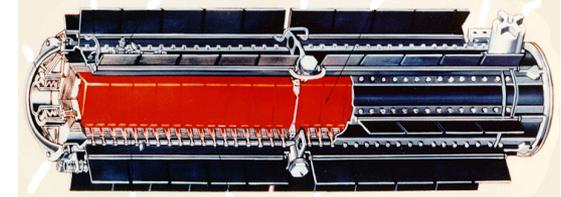
2. Decrease in hot-junction as a result of decreasing heat input (smaller DT = lower Carnot efficiency)

3. Main other mechanisms dependent on time and temperature

- Degradation of thermoelectric properties (lower ZT values)
- Sublimation losses (increased TE leg electrical & thermal resistance)
- Thermoelectric couple interfaces (increased electrical contact resistances)
- Thermal insulation (reduced thermal efficiency)



GPHS RTG



~ 0.8%/year decrease in power output

+

~ 0.5%/year decrease in power output

+

Decrease in power output:
~ 0.3%/year
(~5% over 14 years)

=

Decrease in power output:
~ 1.6%/year total
(22% total over 14 years of operation)



Establishing life time performance

- **Component life test**
 - **Subjects for component life test**
 - Sublimation
 - Thermoelectric properties of materials
 - Bonding interfaces
 - **Design, fabricate and test coupons to quantify each degradation mechanism and assess kinetics**
 - **Test duration will depend on kinetics**
 - **Develop models**
- **Couple life test**
 - **Steady state nominal and accelerated operating conditions**
 - **Prototypic single couple and multi-couple assembly**
- **Update performance model (DEGRA) and validate predictions**



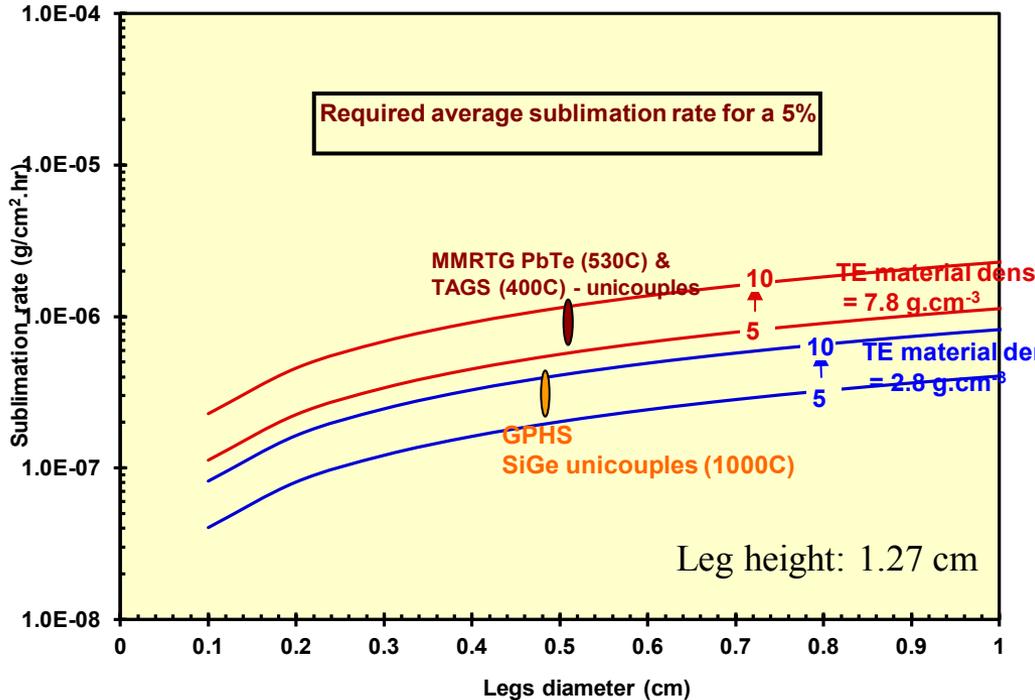
Component life test (sublimation life test)



Sublimation suppression

- **Sublimation suppression goal**

- 10% cross sectional reduction at the hot end of the leg after 14 years operation (2~3% reduction in power output)



- **Sublimation phenomenon**

- Most of TE materials used in power generation have peak figures of merit at the temperature where sublimation is a non-negligible mechanism
- Sublimation leads to reduction of effective cross section, which leads to decrease in power output
- Sublimated species can condense on cold side, which can cause short circuit on the device.
- State of practice power generation thermoelectric couples have always some measure of sublimation control.

- **Background on previous sublimation suppression methods**

- SiGe technology employed Si₃N₄ thin films
- PbTe/TAGS technology employed an inert cover gas and solid insulation
- Skutterudite technology uses opacified aerogel

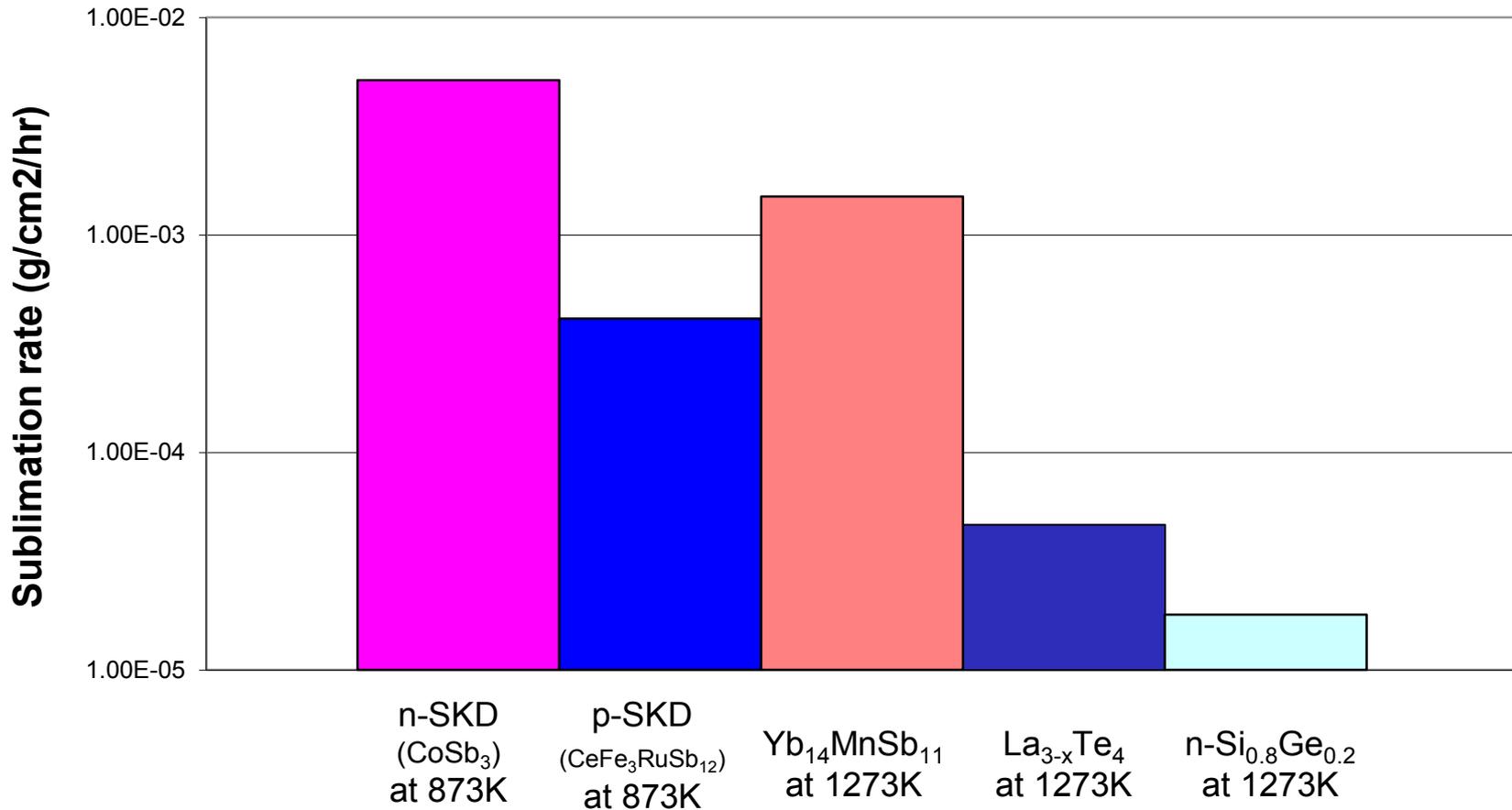
- **Requirements for sublimation suppression barriers**

- Chemical stability against TE materials
- Thermal stability at the operating temperature
- Withstanding stress during thermal cycling
- No significant effect on system performance



Beginning of life sublimation rate of bare TE materials in vacuum

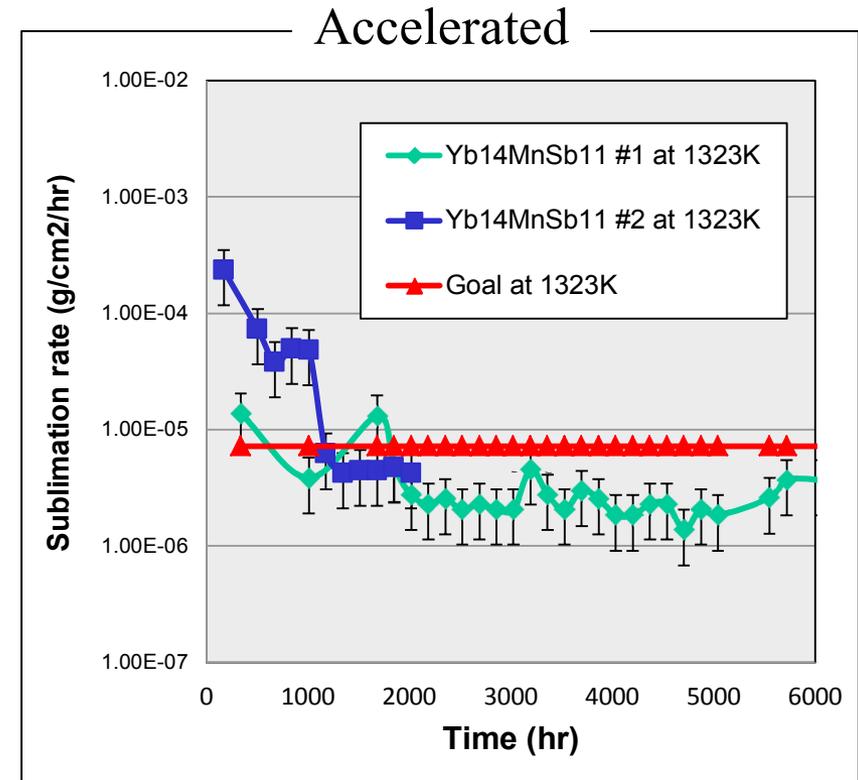
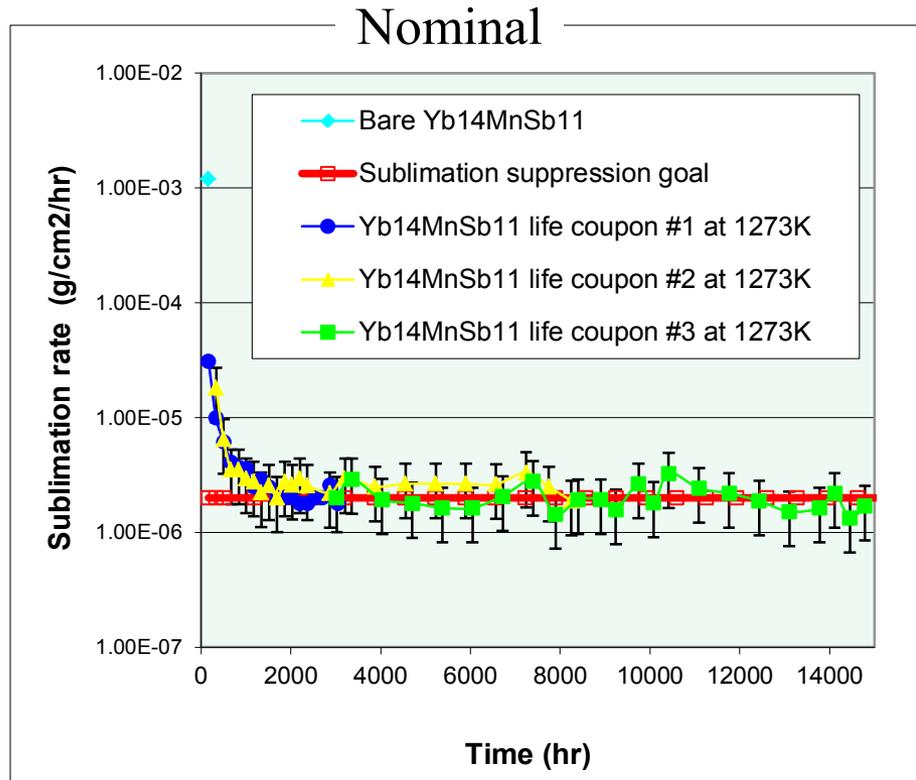
Initial baseline sublimation rates of bare TE materials under vacuum



- All the thermoelectric materials for RTG require some measure of sublimation suppression scheme (need 10^{-6} to 10^{-7} g/cm²/hr)



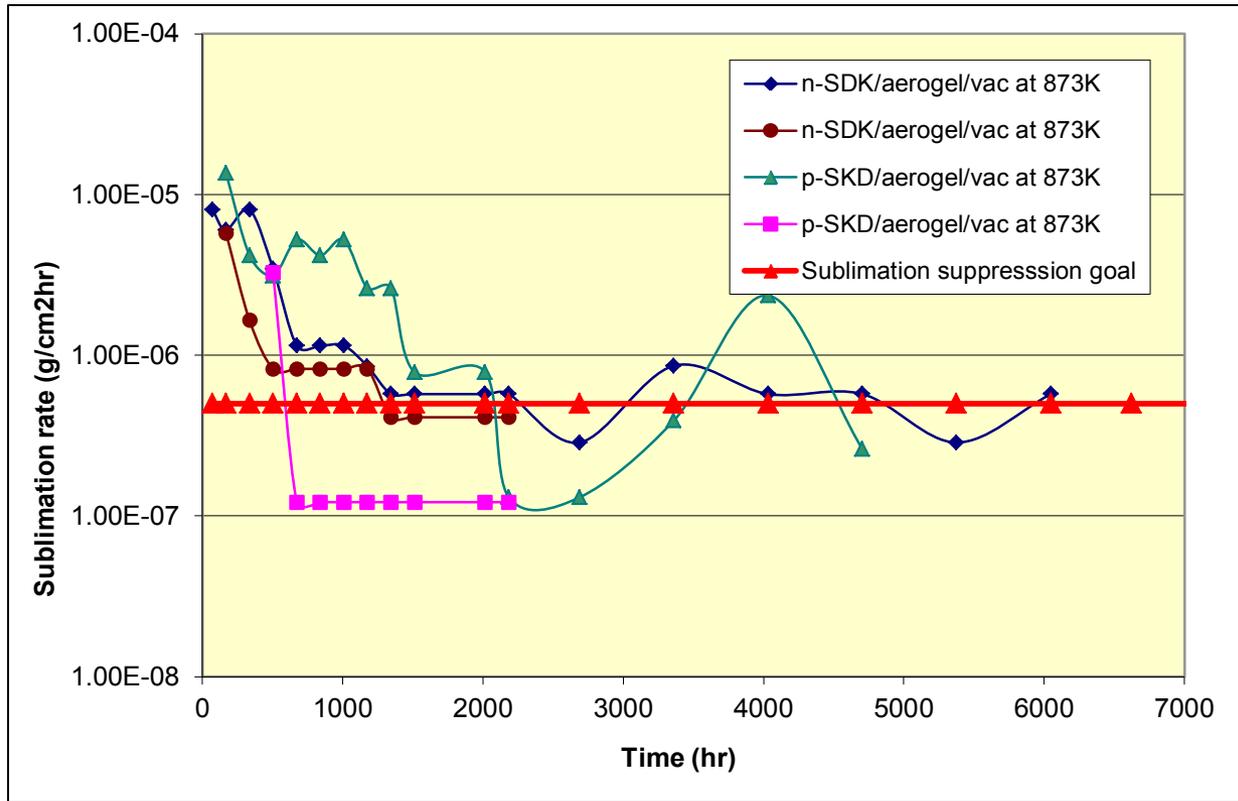
Yb₁₄MnSb₁₁ sublimation life test with porous alumina layer at 1273K and 1323K



- Sublimation rate continuously met the goal during 18 month coupon test.
- Accelerated test at 1323K also confirmed sublimation suppression of Yb₁₄MnSb₁₁ with alumina paste layer
- In spite of several thermal cycles, sublimation rates remained unaffected.
- Successfully demonstrated life time control of sublimation of Yb₁₄MnSb₁₁



Skutterudite sublimation life test with aerogel at 873K



- Sublimation rate continuously met the goal during 6 month coupon test.
- In spite of several thermal cycles, sublimation rates remained unaffected.
- Successfully demonstrated life time control of sublimation of skutterudite

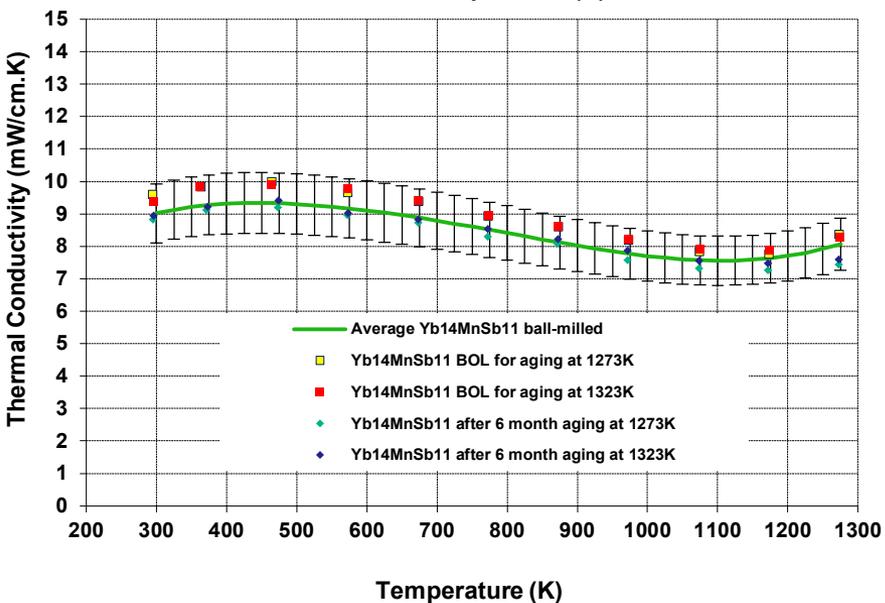
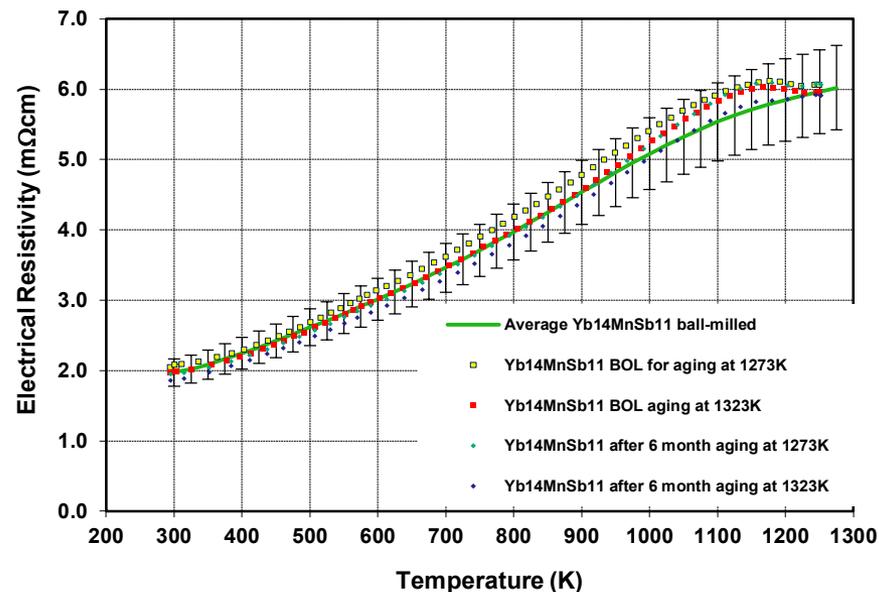
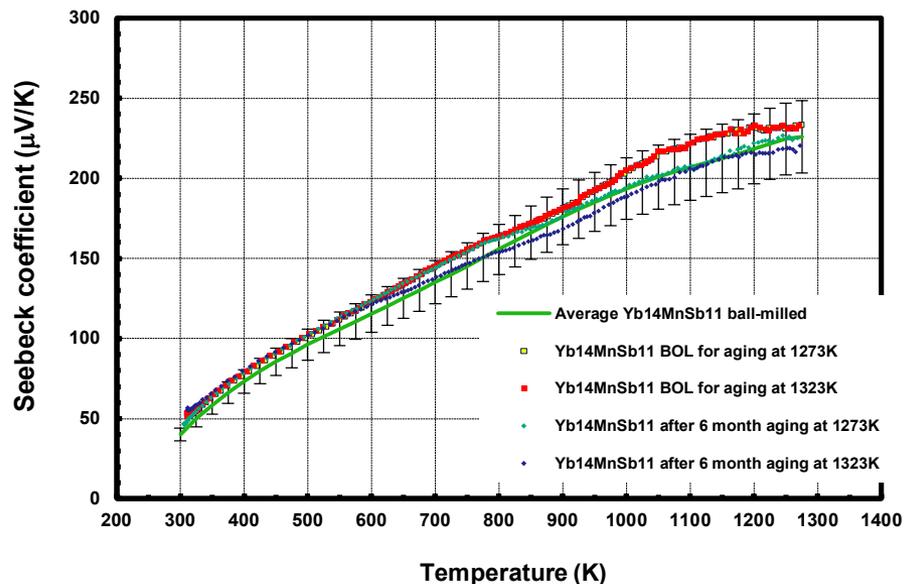


Component life test

(TE properties life test)



Stable TE properties for $\text{Yb}_{14}\text{MnSb}_{11}$

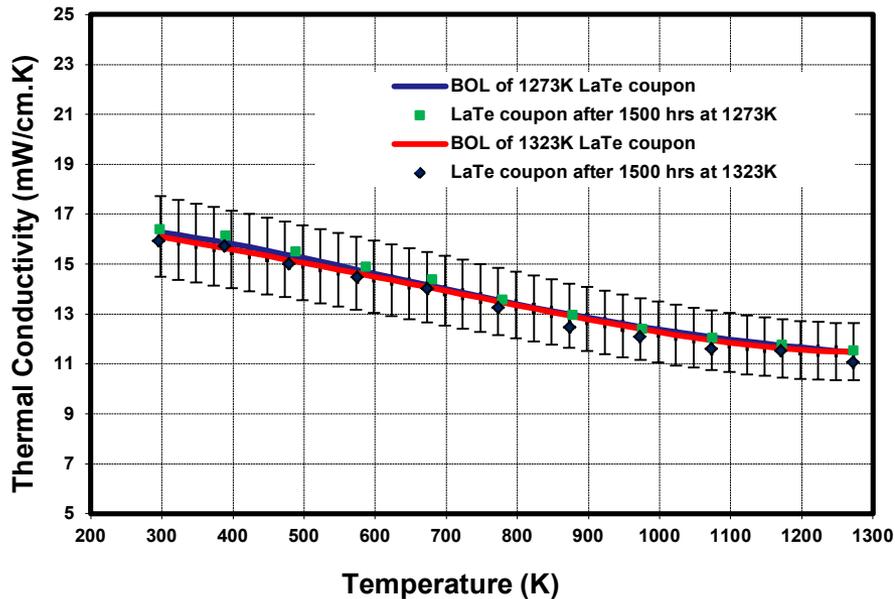
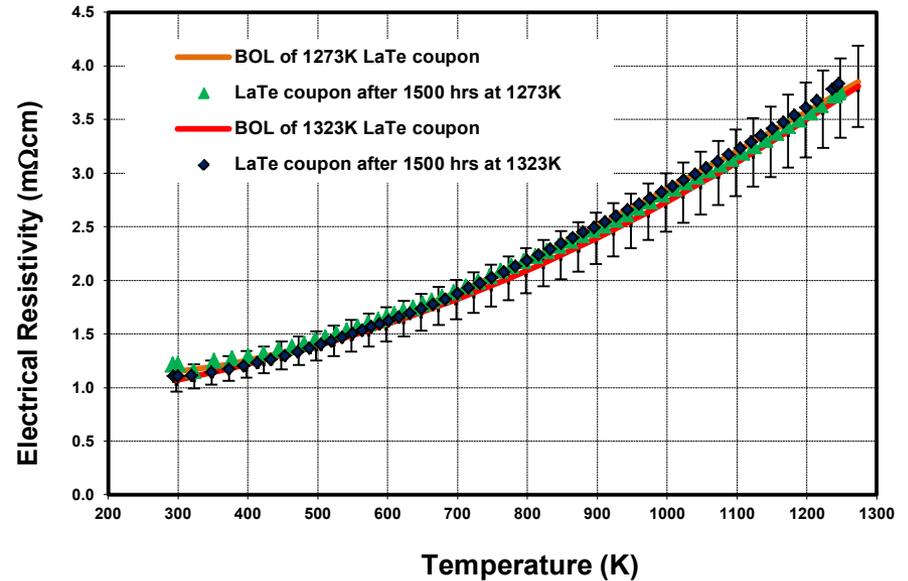
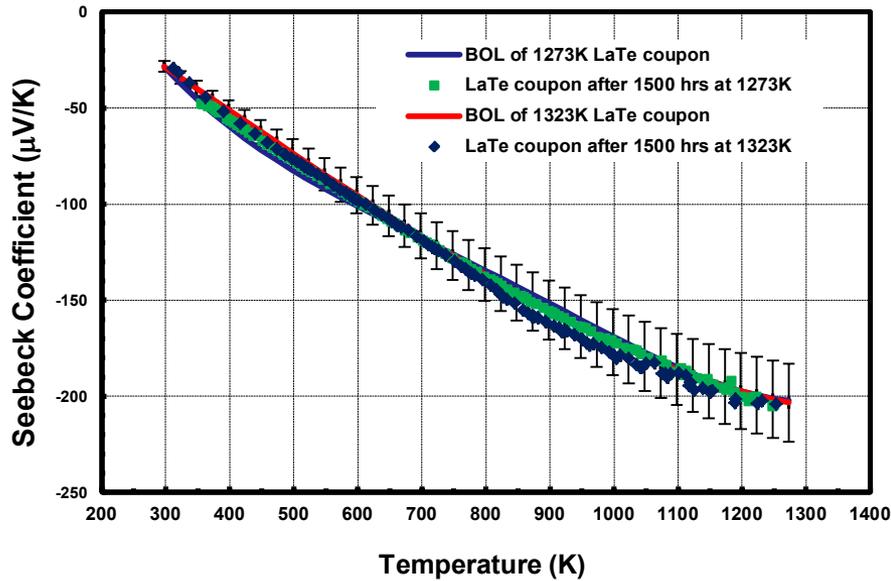


5000hr – nominal and accelerated operating conditions (1273 K and 1323K)

All the three TE properties of $\text{Yb}_{14}\text{MnSb}_{11}$ (Seebeck coefficient, electrical resistance, and thermal conductivity) remained unchanged



Stable TE properties for $\text{La}_{3-x}\text{Te}_4$



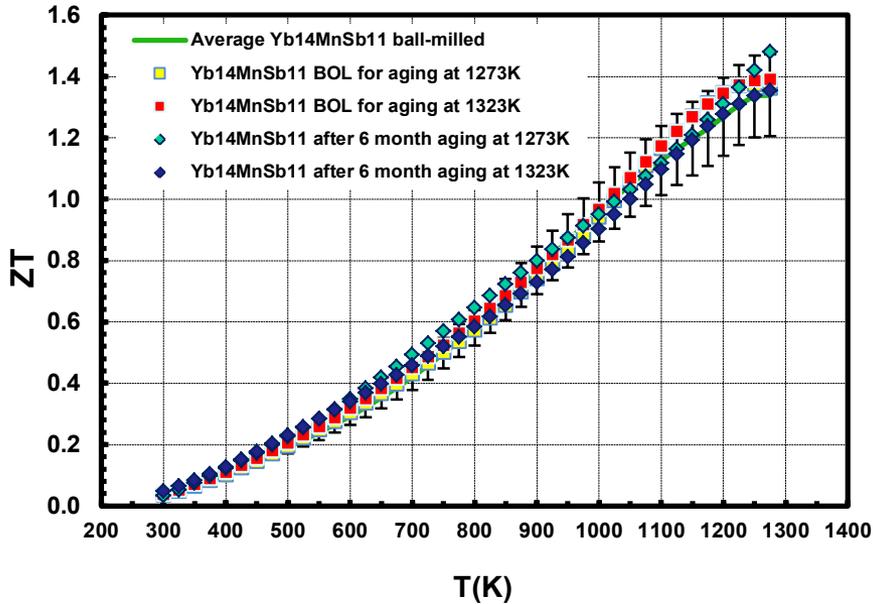
1500hr – nominal and accelerated operating conditions (1273 K and 1323K)

All the three TE properties of $\text{La}_{3-x}\text{Te}_4$ (Seebeck coefficient, electrical resistance, and thermal conductivity) remained unchanged

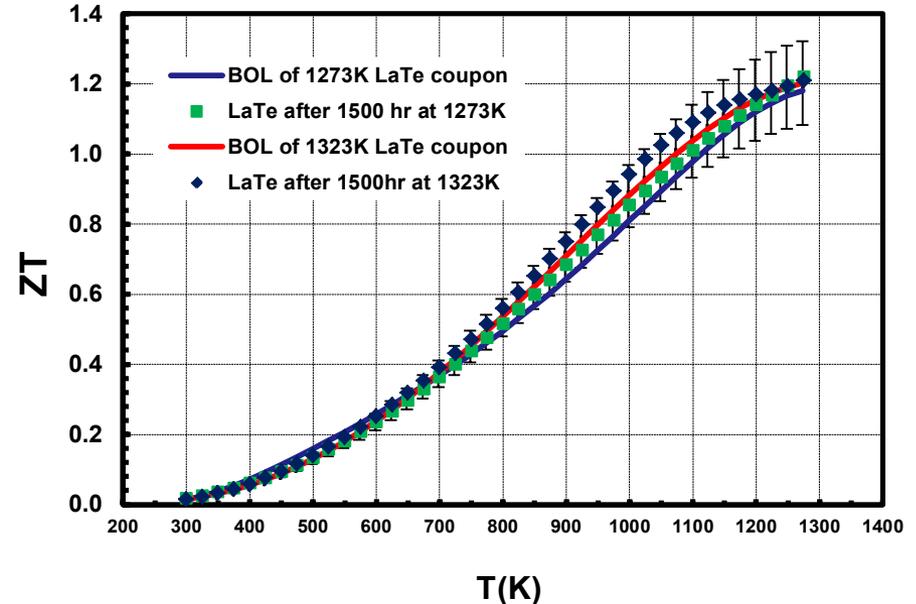


Stable Figure of Merit of $\text{Yb}_{14}\text{MnSb}_{11}$ and $\text{La}_{3-x}\text{Te}_4$

$\text{Yb}_{14}\text{MnSb}_{11}$ after 6 month aging



$\text{La}_{3-x}\text{Te}_4$ after 2 month aging



- Figure of merit was maintained after aging at either 1273K or 1323K
- There is no degradation on TE properties of $\text{Yb}_{14}\text{MnSb}_{11}$ and $\text{La}_{3-x}\text{Te}_4$ after aging at either 1273K or 1323K.
- Further life test is in-progress



Component life test

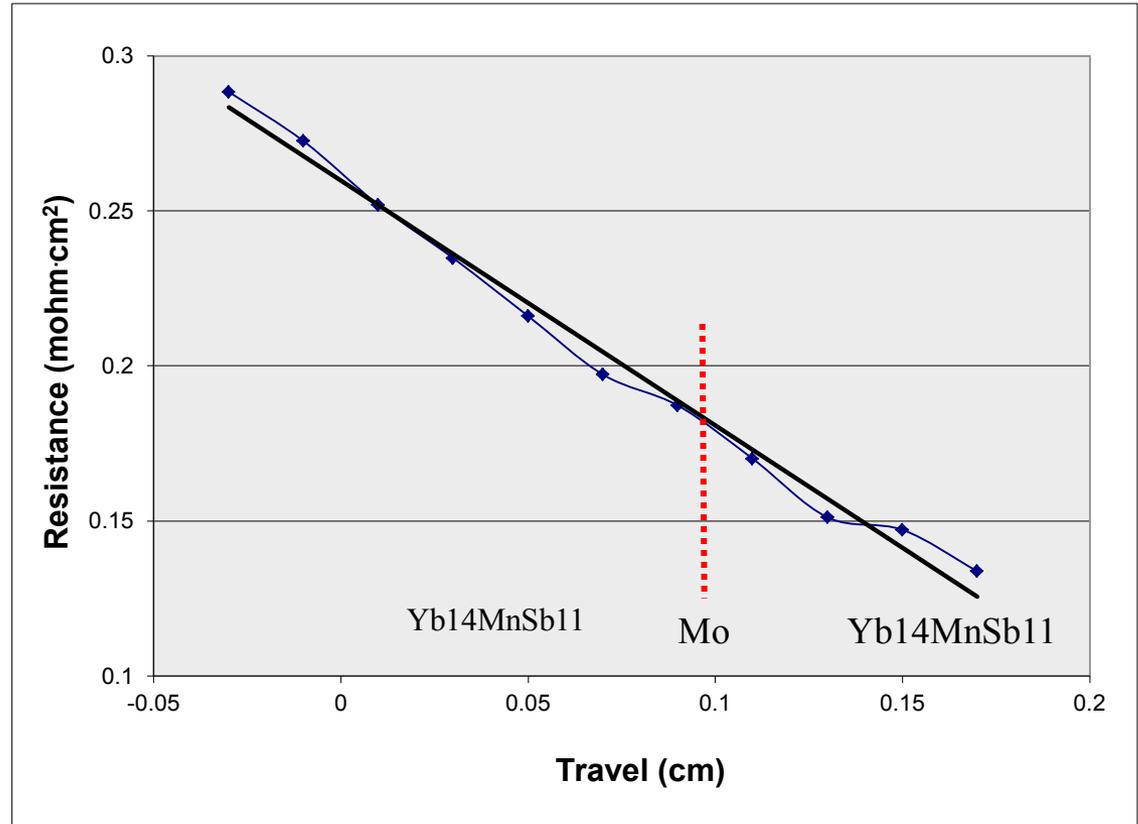
(Contact resistance life test)



Yb₁₄MnSb₁₁ Electrical Contact Resistance Life Test Stable Performance after 1500 hr aging at 1273K



Yb₁₄MnSb₁₁/Mo/Yb₁₄MnSb₁₁ coupon
after 1500 hr aging at 1273K



- A Yb₁₄MnSb₁₁/Mo/Yb₁₄MnSb₁₁ coupon showed no measurable contact resistance after 1500 hr at 1273K.



Status of TE materials for high efficiency couples

	n-type Skutterudite	p-type Skutterudite	Yb ₁₄ MnSb ₁₁ (Zintl)	La _{3-x} Te ₄
Maximum operating temperature	873K	873K	1273K	1273K
Average ZT	1.01 [873 to 473K]	0.78 [873 to 473K]	0.98 [1273 to 773K]	0.88 [1273 to 473K]
TE Properties life test	>10,000 hrs at 873 K (from couple test)		>5,000 hrs at 1273K and 1323K	> 1,500 hrs at 1273K and 1323K
Sublimation suppression	<u>Demonstrated</u> with aerogel (5× 10 ⁻⁷ g/cm ² /hr for 6000 hrs at 873K)		<u>Demonstrated</u> with alumina paste (2× 10 ⁻⁶ g/cm ² /hr for >15,000 hrs at 1273K)	Not required up to 1173K
Contact Metallization	>1500 hr aging at 873 K		>1500 hr aging at 1273K	>1000 hr aging at 1273K



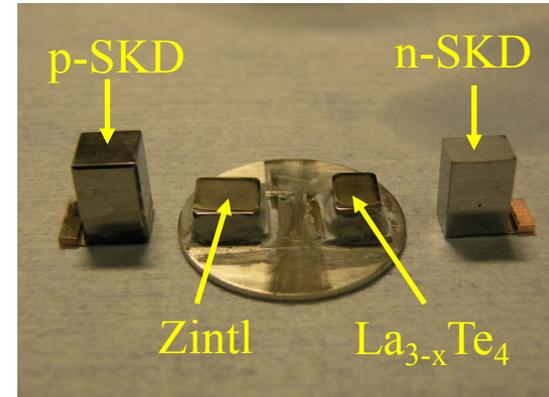
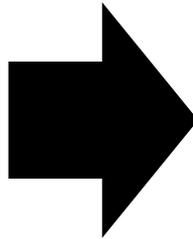
Couple life test



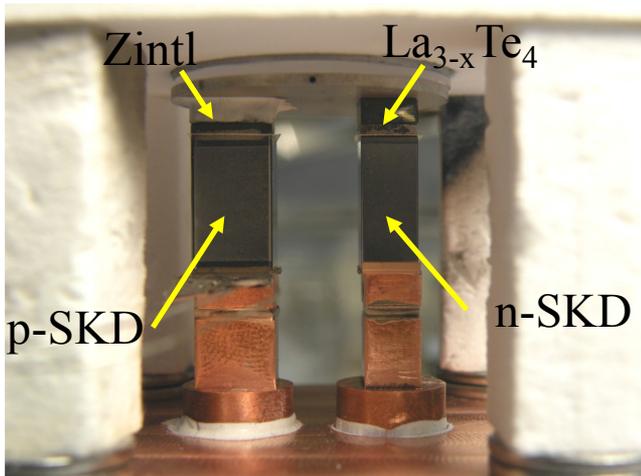
Couple Fabrication and Assembly



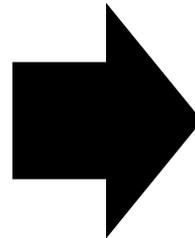
Fixturing for Couple Component Fabrication



Couple Fabrication – HT stage and LT segments



Couple assembled in test fixture

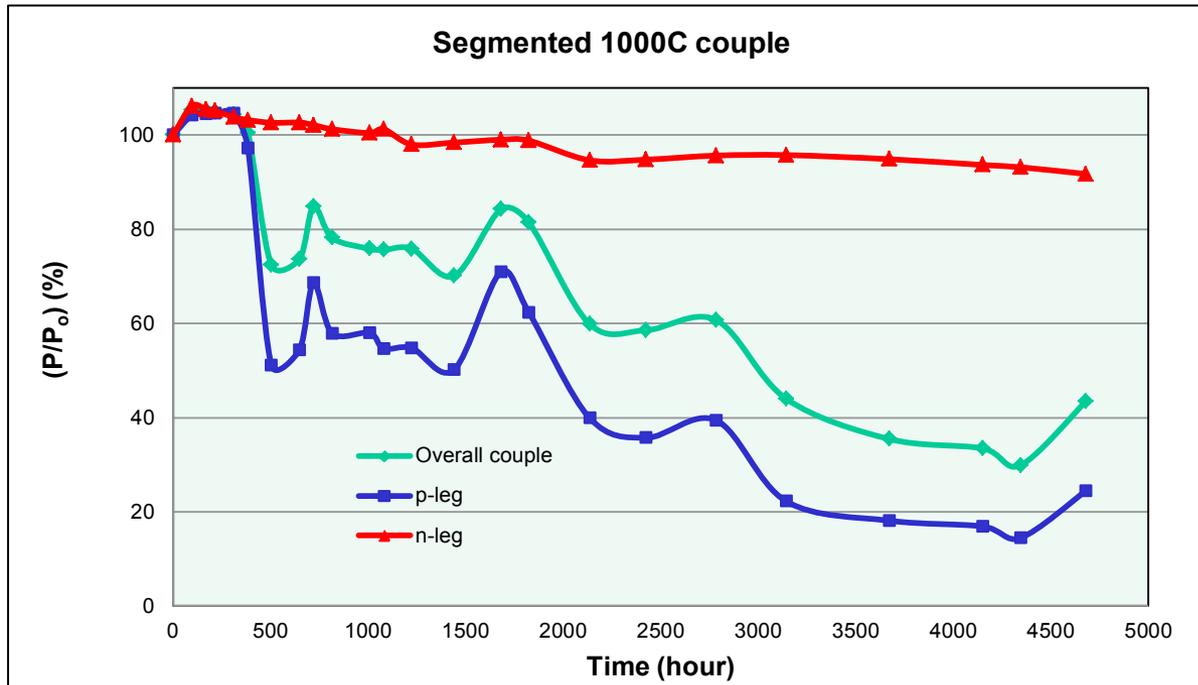


Sublimation coating applied & thermal insulation installation



Extended Testing of 1000 C Couples

Couple Performance vs. Time

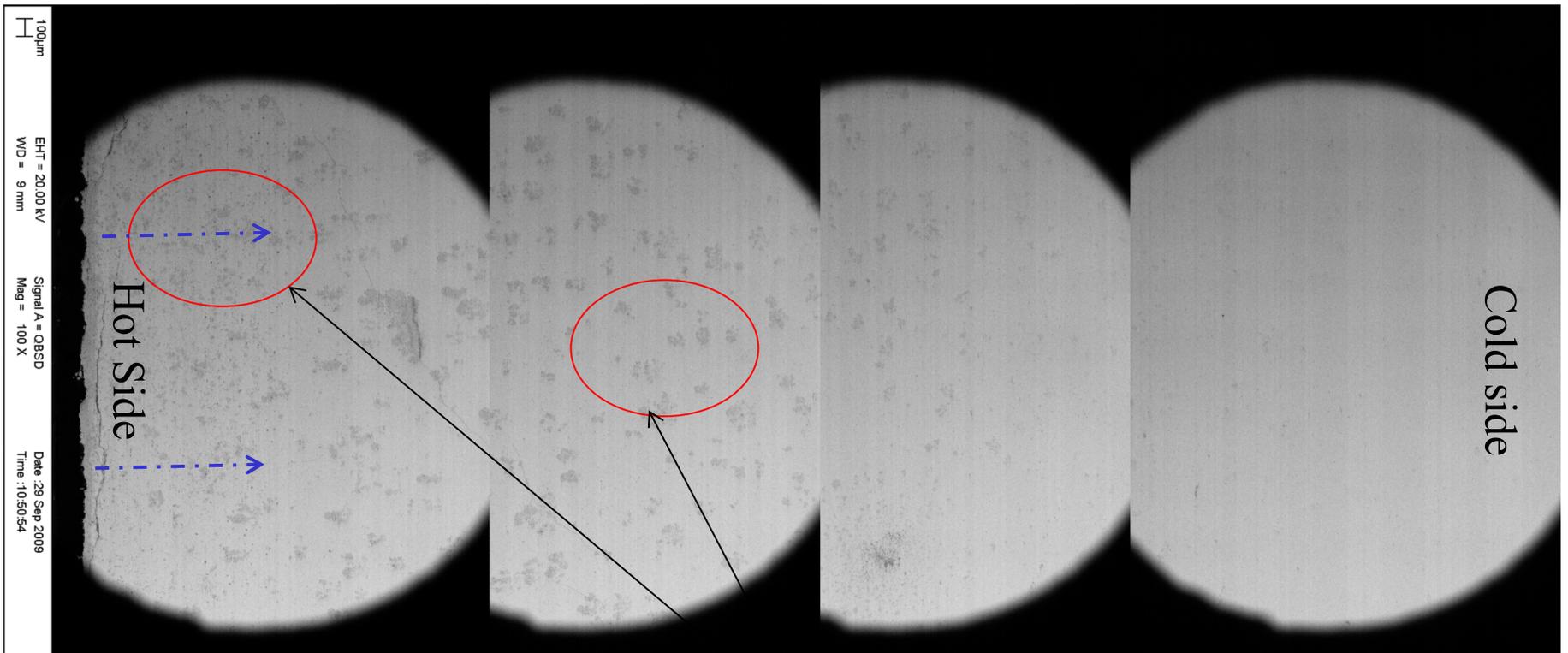


- Extended testing performed on several segmented couples
- ~95% of BOL power output was maintained after 5000 hr operation of 800C segmented couples.
- Performance decrease with time is highly dependent on maximum operating temperature
- Hot side interfaces are main root cause
 - Especially significant for Zintl p-leg



Hot Side Interface Stability Challenges

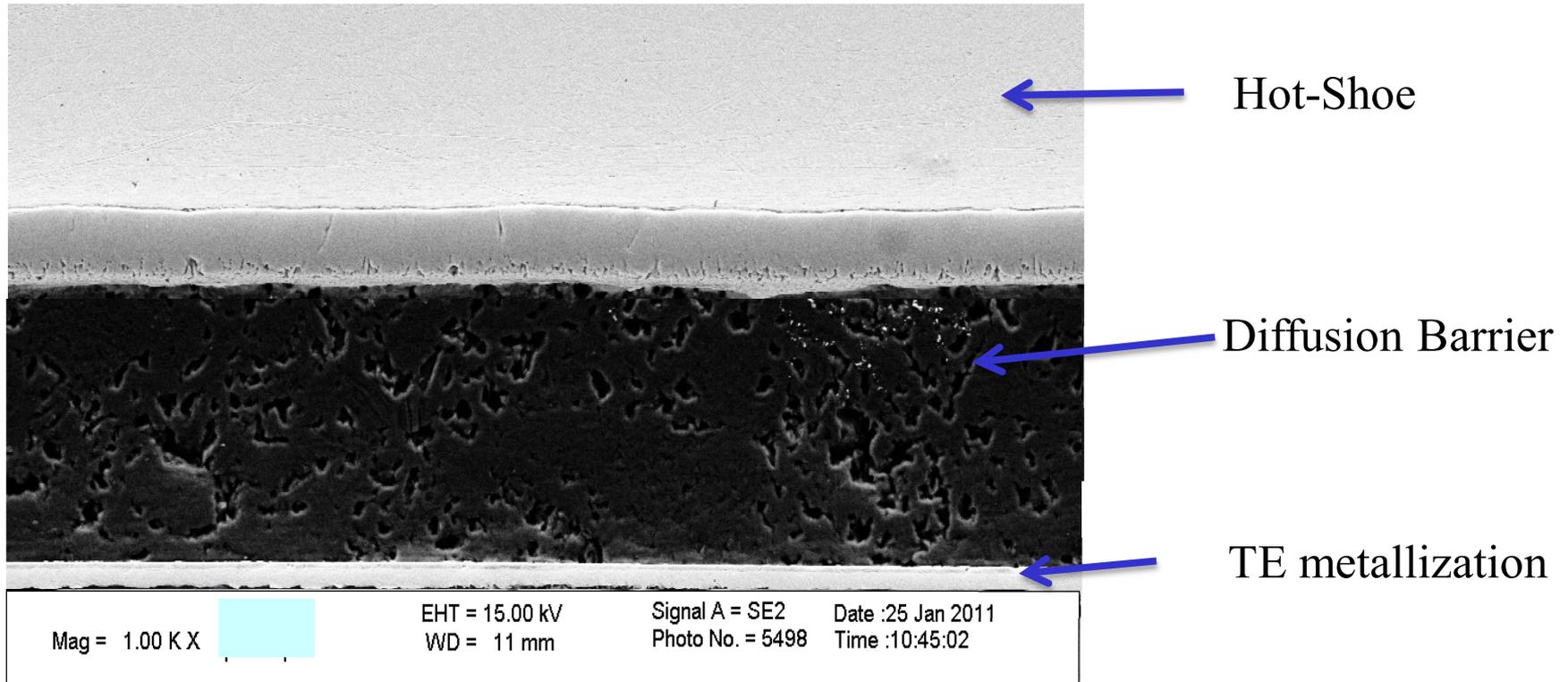
- Hot shoe interface degradation limits lifetime of current couple configurations operating above 1073K hot side temperatures
- Development of diffusion barriers to protect metal/TE contacts is required



Hot shoe metal poisoning in p-Zintl leg of unsegmented couple after > 1000 hour operation at $T_h \sim 1273$ K (composite view)



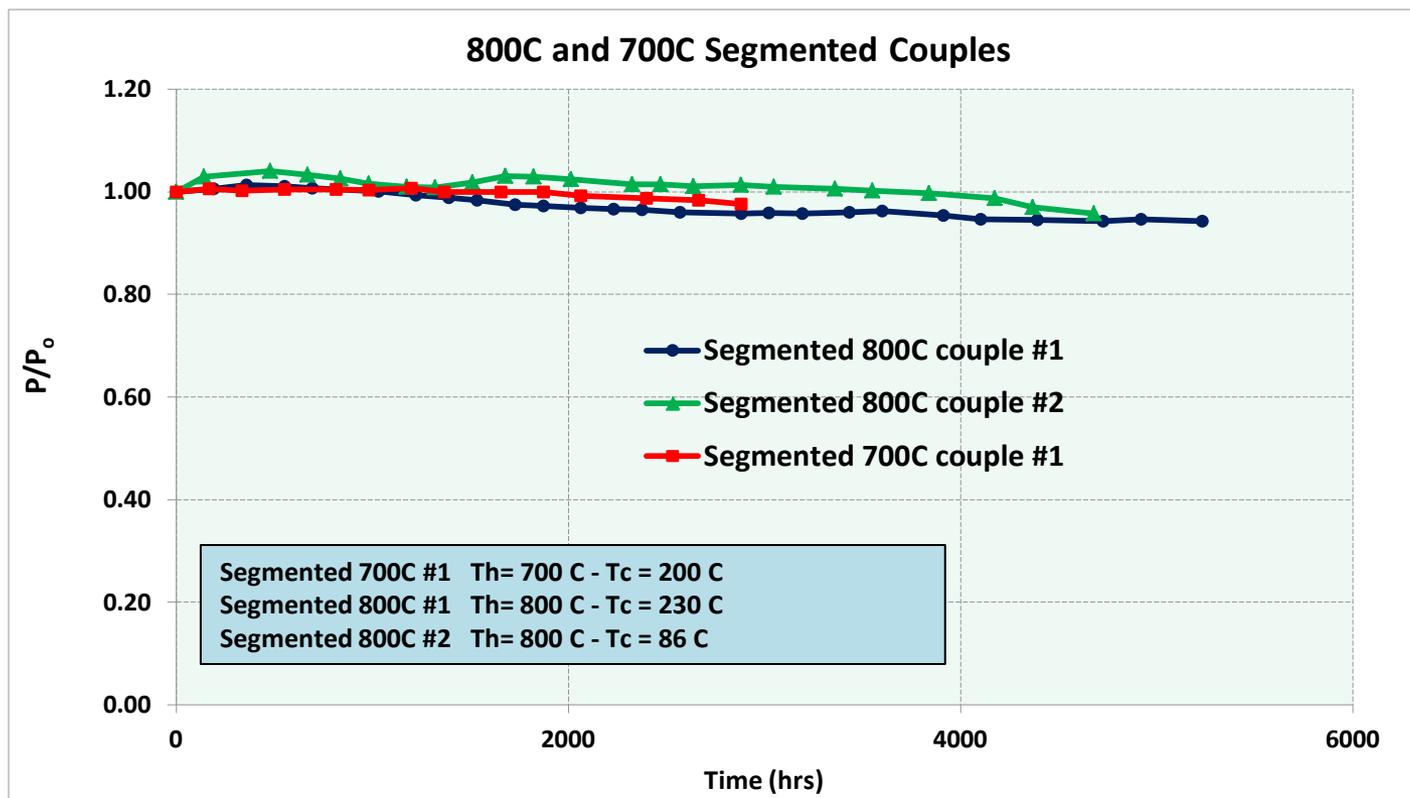
Hot Side Diffusion Barrier Development



- Several promising candidates have been identified
- Currently doing extended testing at the coupon level
- Planning on integrating diffusion barriers in next series of couples



Extended Testing of 800C and 700C Segmented Couples



- **700C and 800C segmented couples maintained most of BOL power output during extended couple testing**
 - 800C segmented couples: ~95% of BOL power output after 5000 hr operation
 - 700C segmented couples: ~97% of BOL power output after 3000 hr operation
- **Degradation of p-leg (Zintl) from hot shoe metal poisoning is alleviated when the couples are operated at lower temperature.**



Segmented Couples – Current Status

	Segmented spring-loaded couple			
Upper segments	p-Yb ₁₄ MnSb ₁₁ Zintl/n-La _{3-x} Te ₄			
Lower segments	p-SKD/n-SKD (Filled Skutterudites)			
Hot/ cold side temperature (K)	1273/473	1173/473	1073/473	973/473
	(T _{SKD-interface} ~ 873K)			
BOL predicted couple efficiency	13.7%	12.5%	11.2%	10.0%
Comments	Validated at BOL (14.8%) (1500 h to date)	Not fabricate d to date	Validated at BOL (11%) Maintained ~95% of BOL power output after 5000hrs	Validated at BOL (10%) Maintained ~97% of BOL power output after 3000hrs



Summary

- **Component life demonstrated that Skutterudites, $\text{Yb}_{14}\text{MnSb}_{11}$, and $\text{La}_{3-x}\text{Te}_4$ are acceptable for long life operation**
 - Vacuum or inert gas operation
 - Life test results to date indicate that these TE materials are ready for couple technology development (further verification is in-progress with extended life tests).
- **Developed effective sublimation suppression methods**
 - Porous coating on $\text{Yb}_{14}\text{MnSb}_{11}$
 - Aerogel on skutterudites
 - Assessment of sublimation kinetics indicates that the sublimation rate is likely to remain unchanged for the desired life time.
- **Segmented couple test demonstrated achieving predicted BOL efficiency**
- **Lower temperature segmented couples maintained BOL power output during life test**
 - 800C segmented couple : ~ 95% of BOL power output after 5000hr operation
 - 700C segmented couple : ~ 97% of BOL power output after 3000hr operation
- **On-going and future coupon and couples performance life tests will be used to verify degradation rates**



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